

Description

The XXW4485 uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a Battery protection or in other Switching application.



General Features

SOP-8

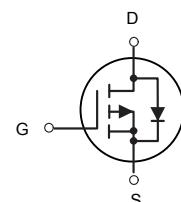
 $V_{DS} = -40\text{ V}$ $I_D = -13\text{ A}$
 $R_{DS(ON)} < 19\text{ m}\Omega$ @ $V_{GS}=10\text{ V}$

Application

Battery protection

Load switch

Uninterruptible power supply



P-Channel MOSFET

Absolute Maximum Ratings ($T_c=25^\circ\text{C}$ unless otherwise noted)

| Symbol | Parameter | Rating | Units |
|----------------------------|---|------------|---------------------------|
| V_{DS} | Drain-Source Voltage | - 40 | V |
| V_{GS} | Gate-Source Voltage | ± 20 | V |
| $I_D@T_A=25^\circ\text{C}$ | Drain Current ³ , $V_{GS} @ 10\text{ V}$ | -13 | A |
| IDM | Pulsed Drain Current ¹ | -52 | A |
| $P_D@T_A=25^\circ\text{C}$ | Total Power Dissipation | 3 | W |
| T_{STG} | Storage Temperature Range | -55 to 150 | $^\circ\text{C}$ |
| T_J | Operating Junction Temperature Range | -55 to 150 | $^\circ\text{C}$ |
| R_{thj-a} | Maximum Thermal Resistance, Junction-ambient ³ | 41 | $^\circ\text{C}/\text{W}$ |

Electrical Characteristics (T_J = 25°C, unless otherwise noted)

| Parameter | Symbol | Test Conditions | Min. | Typ. | Max. | Unit |
|--|----------------------|---|------|------|------|------|
| Static Characteristics | | | | | | |
| Drain-Source Breakdown Voltage | V _{(BR)DSS} | V _{GS} = 0V, I _D = -250μA | -40 | - | - | V |
| Gate-body Leakage current | I _{GSS} | V _{DS} = 0V, V _{GS} = ±20V | - | - | ±100 | nA |
| Zero Gate Voltage Drain Current T _J =25°C T _J =100°C | I _{DSS} | V _{DS} = -40V, V _{GS} = 0V | - | - | -1 | μA |
| | | | - | - | -100 | |
| Gate-Threshold Voltage | V _{GS(th)} | V _{DS} = V _{GS} , I _D = -250μA | -1.0 | -1.5 | -2.2 | V |
| Drain-Source On-Resistance ⁴ | R _{D(on)} | V _{GS} = -10V, I _D = -10A | - | 14.0 | 19 | mΩ |
| | | V _{GS} = -4.5V, I _D = -5 A | - | 19.5 | 25 | |
| Forward Transconductance ⁴ | g _{fs} | V _{DS} = -10V, I _D = -10A | - | 44 | - | S |
| Dynamic Characteristics⁵ | | | | | | |
| Input Capacitance | C _{iss} | V _{DS} = -20V, V _{GS} = 0V, f = 1MHz | - | 2525 | - | pF |
| Output Capacitance | C _{oss} | | - | 190 | - | |
| Reverse Transfer Capacitance | C _{rss} | | - | 172 | - | |
| Gate Resistance | R _g | f = 1MHz | - | 10 | - | Ω |
| Switching Characteristics⁵ | | | | | | |
| Total Gate Charge | Q _g | V _{GS} = -10V, V _{DS} = -20V, I _D = -10A | - | 35 | - | nC |
| Gate-Source Charge | Q _{gs} | | - | 5.5 | - | |
| Gate-Drain Charge | Q _{gd} | | - | 8 | - | |
| Turn-On Delay Time | t _{d(on)} | V _{GS} = -10V, V _{DD} = -20V, R _G = 3Ω, I _D = -10A | - | 14.5 | - | ns |
| Rise Time | t _r | | - | 20.2 | - | |
| Turn-Off Delay Time | t _{d(off)} | | - | 32 | - | |
| Fall Time | t _f | | - | 10 | - | |
| Drain-Source Body Diode Characteristics | | | | | | |
| Diode Forward Voltage ⁴ | V _{SD} | I _S = -10A, V _{GS} = 0V | - | - | -1.2 | V |
| Continuous Source Current | T _C =25°C | I _S | - | - | -13 | A |

Note :

- Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150°C.
- The EAS data shows Max. rating . The test condition is V_{DD}= -25V, V_{GS}= -10V, L= 0.1mH, I_{AS}= -34A.
- The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper, The value in any given application depends on the user's specific board design.
- The data tested by pulsed , pulse width ≤ 300us , duty cycle ≤ 2%.
- This value is guaranteed by design hence it is not included in the production test.

Typical Characteristics

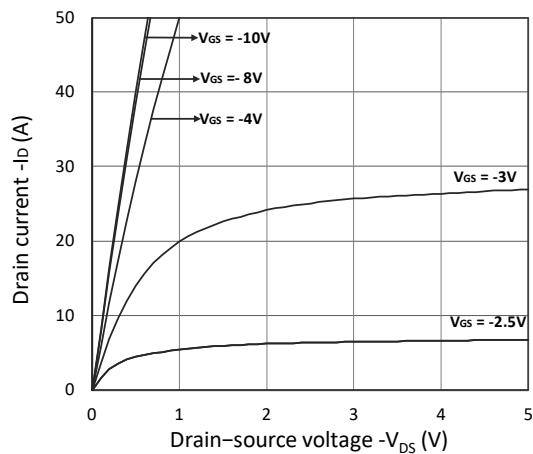


Figure 1. Output Characteristics

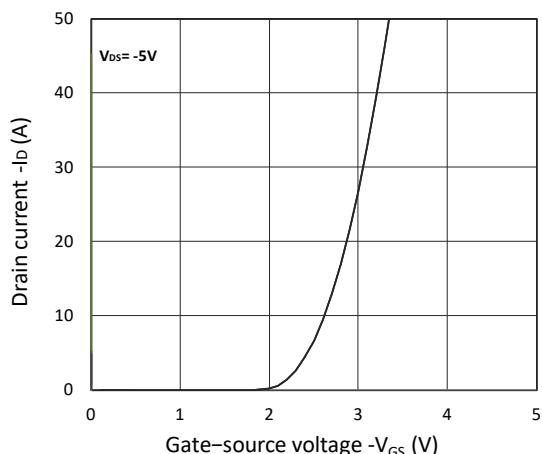


Figure 2. Transfer Characteristics

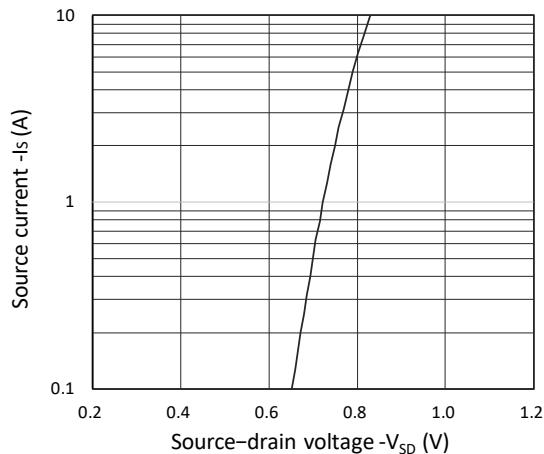


Figure 3. Forward Characteristics of Reverse

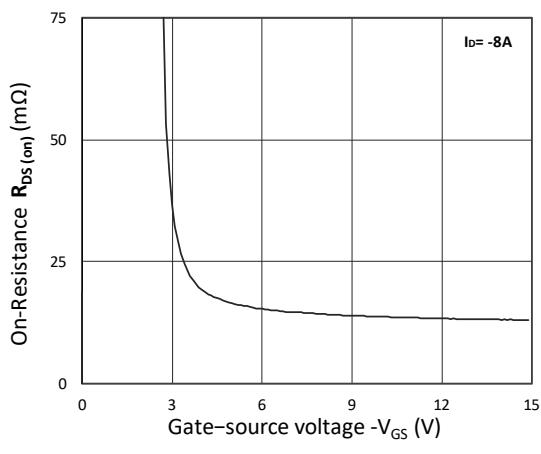


Figure 4. $R_{DS(on)}$ vs. V_{GS}

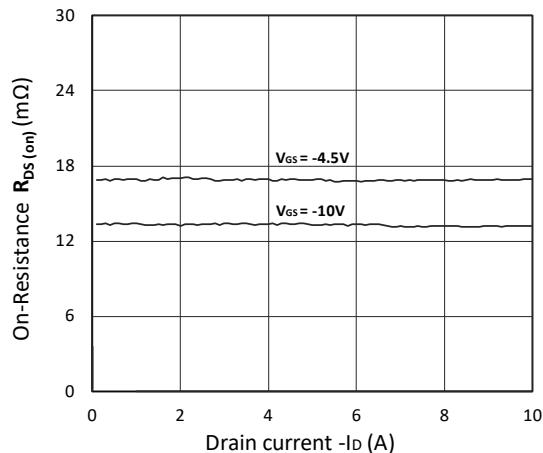


Figure 5. $R_{DS(on)}$ vs. I_D

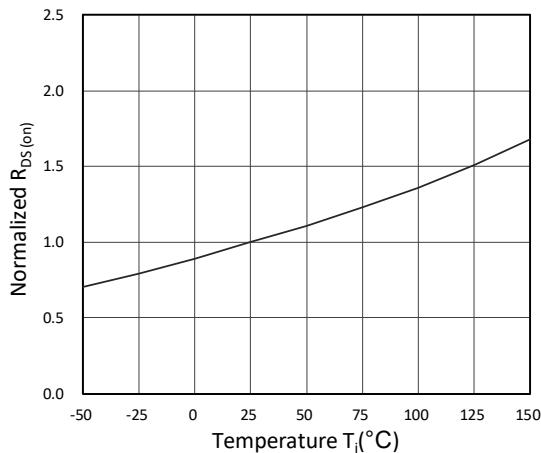


Figure 6. Normalized $R_{DS(on)}$ vs. Temperature

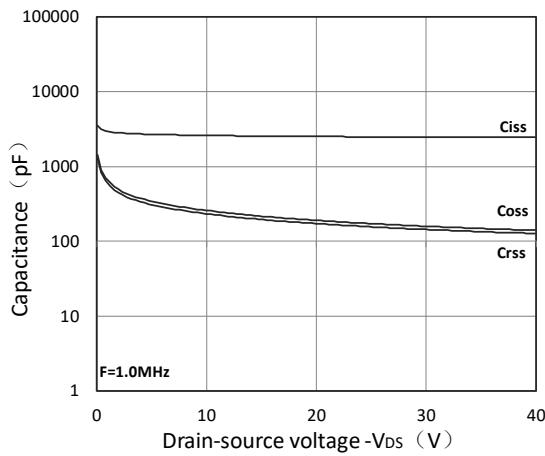


Figure 7. Capacitance Characteristics

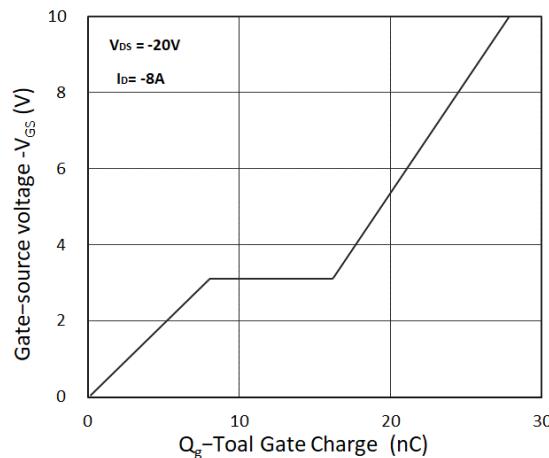


Figure 8. Gate Charge Characteristics

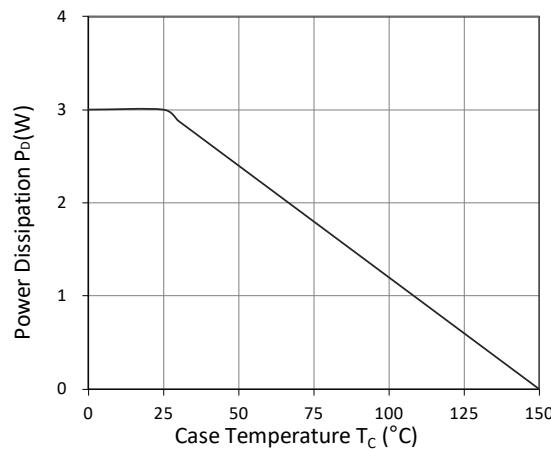


Figure 9. Power Dissipation

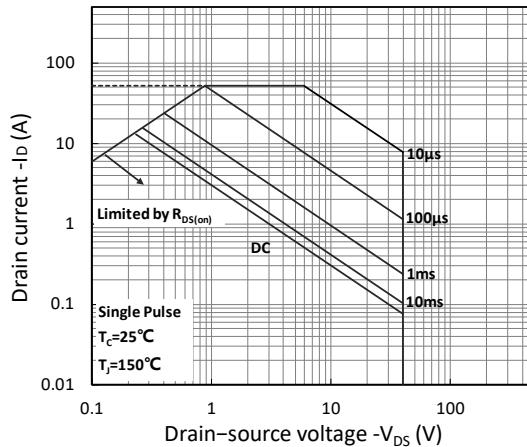


Figure 10. Safe Operating Area

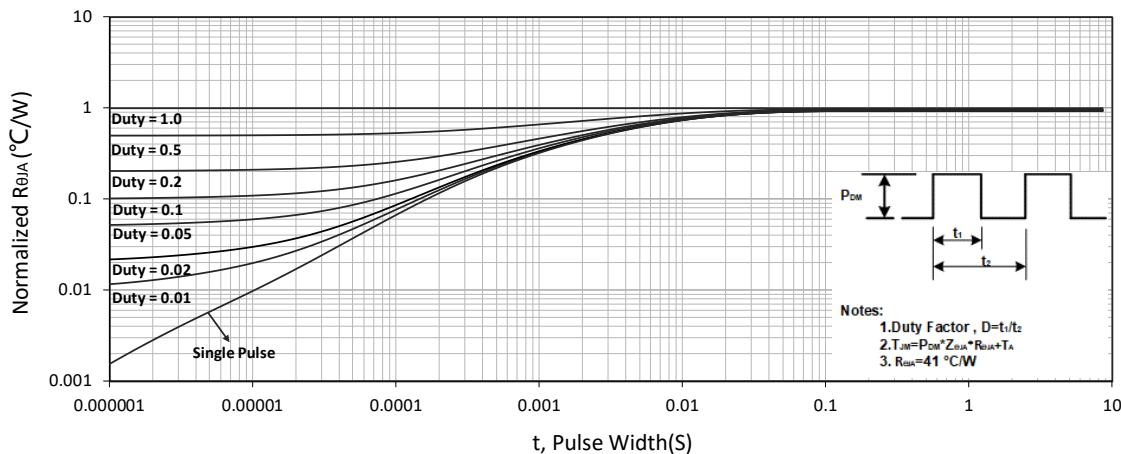


Figure 11. Normalized Maximum Transient Thermal Impedance

Test Circuit

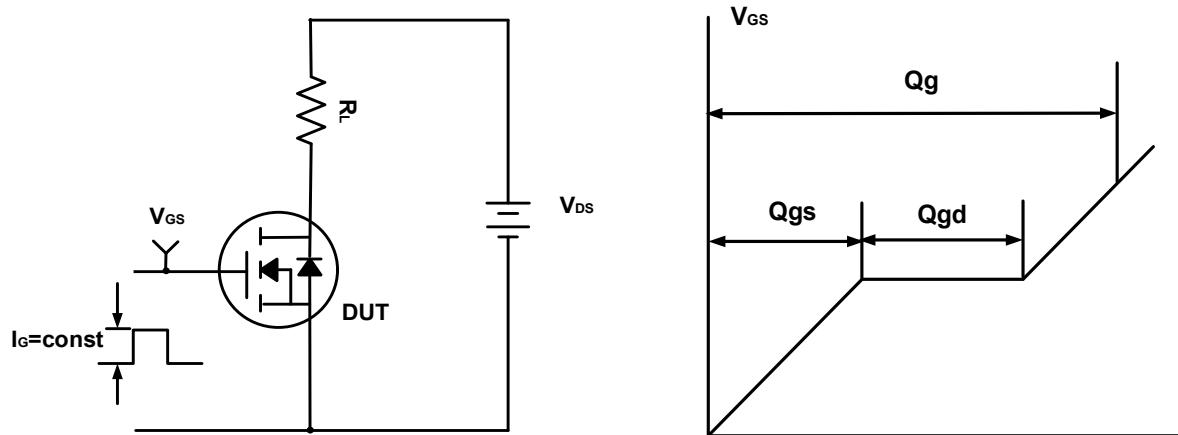


Figure A. Gate Charge Test Circuit & Waveforms

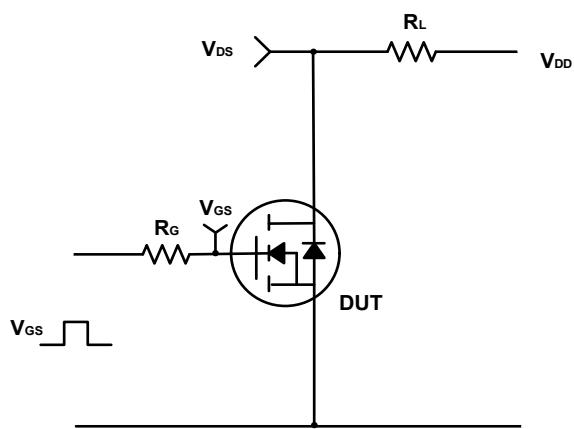


Figure B. Switching Test Circuit & Waveforms

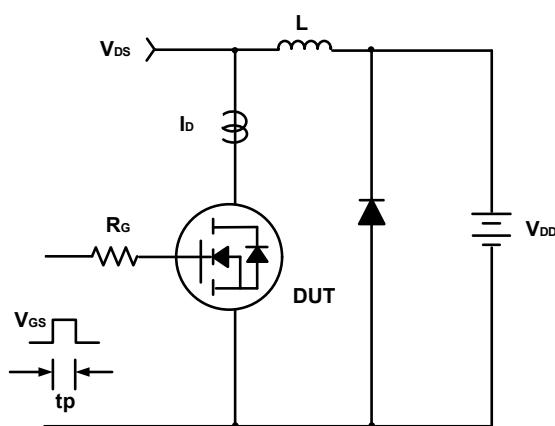
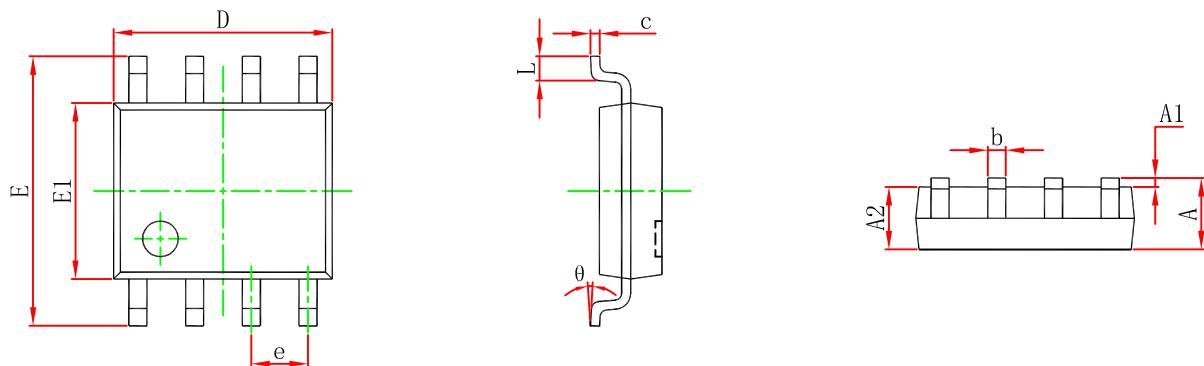
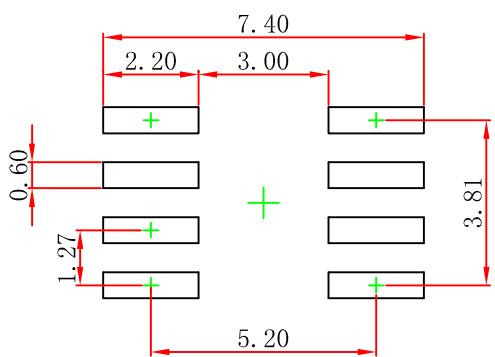


Figure C. Unclamped Inductive Switching Circuit & Waveforms

SOP-8 Package Outline Dimensions



| Symbol | Dimensions In Millimeters | | Dimensions In Inches | |
|--------|---------------------------|-------|----------------------|-------|
| | Min | Max | Min | Max |
| A | 1.350 | 1.750 | 0.053 | 0.069 |
| A1 | 0.100 | 0.250 | 0.004 | 0.010 |
| A2 | 1.350 | 1.550 | 0.053 | 0.061 |
| b | 0.330 | 0.510 | 0.013 | 0.020 |
| c | 0.170 | 0.250 | 0.007 | 0.010 |
| D | 4.800 | 5.000 | 0.189 | 0.197 |
| e | 1.270 (BSC) | | 0.050 (BSC) | |
| E | 5.800 | 6.200 | 0.228 | 0.244 |
| E1 | 3.800 | 4.000 | 0.150 | 0.157 |
| L | 0.400 | 1.270 | 0.016 | 0.050 |
| θ | 0° | 8° | 0° | 8° |



Note:
 1. Controlling dimension: in millimeters.
 2. General tolerance: $\pm 0.05\text{mm}$.
 3. The pad layout is for reference purposes only.